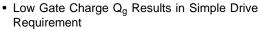


### N-Channel 650V (D-S) Power MOSFET

| PRODUCT SUMMARY                 |                          |  |  |  |  |
|---------------------------------|--------------------------|--|--|--|--|
| V <sub>DS</sub> (V)             | 650                      |  |  |  |  |
| $R_{DS(on)}\left(\Omega\right)$ | V <sub>GS</sub> = 10 V 5 |  |  |  |  |
| Q <sub>g</sub> (Max.) (nC)      | 11                       |  |  |  |  |
| Q <sub>gs</sub> (nC)            | 2.3                      |  |  |  |  |
| Q <sub>gd</sub> (nC)            | 5.2                      |  |  |  |  |
| Configuration                   | Single                   |  |  |  |  |

#### **FEATURES**

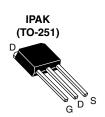


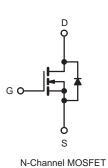


• Improved Gate, Avalanche and Dynamic dV/dt Ruggedness



- Fully Characterized Capacitance and Avalanche Voltage and Current
- Compliant to RoHS directive 2002/95/EC





| ABSOLUTE MAXIMUM RATINGS T <sub>C</sub> = 25 °C, unless otherwise noted |   |                         |                 |               |          |  |
|---|---|-------------------------|-----------------|---------------|----------|--|
| PARAMETER   |   |                         | SYMBOL          | LIMIT         | UNIT     |  |
| Drain-Source Voltage  |   |                         | $V_{DS}$        | 650           | V        |  |
| Gate-Source Voltage   |   |                         | $V_{GS}$        | ± 30          | 7 v      |  |
| Continuous Drain Currente   | V <sub>GS</sub> at 10 V                     | T <sub>C</sub> = 25 °C  | I_              | 2.0           |          |  |
| Continuous Drain Current  | V <sub>GS</sub> at 10 V                     | T <sub>C</sub> = 100 °C | I <sub>D</sub>  | 1.28          | Α        |  |
| Pulsed Drain Current <sup>a</sup>                                       |   |                         | I <sub>DM</sub> | 8             |          |  |
| Linear Derating Factor  |   |                         |                 | 0.48          | W/°C     |  |
| Single Pulse Avalanche Energy <sup>b</sup>                              |   |                         | E <sub>AS</sub> | 165           | mJ       |  |
| Repetitive Avalanche Current <sup>a</sup>                               |   |                         | I <sub>AR</sub> | 2             | Α        |  |
| Repetitive Avalanche Energy <sup>a</sup>                                |   | E <sub>AR</sub>         | 6               | mJ            |          |  |
| Maximum Power Dissipation $T_C = 25  ^{\circ}C$                         |   |                         | $P_{D}$         | 45            | W        |  |
| Peak Diode Recovery dV/dt <sup>c</sup>                                  | dV/dt                                       | 2.8                     | V/ns            |               |          |  |
| Operating Junction and Storage Temperature Range                        |   |                         | $T_J,T_stg$     | - 55 to + 150 | - °C     |  |
| Soldering Recommendations (Peak Temperature) <sup>d</sup>               | ns (Peak Temperature) <sup>d</sup> for 10 s |                         |                 | 300           |          |  |
| Mounting Torque   | 6-32 or N                                   | 6-32 or M3 screw        |                 | 10            | lbf ⋅ in |  |
| woulding Forque   | 0-32 OF IVIS SCIEW                          |                         |                 | 1.1           | N⋅m      |  |

#### Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Starting T $_J$  = 25 °C, L = 24 mH, R $_G$  = 25  $\Omega$ , I $_{AS}$  = 3.2 A (see fig. 12). c. I $_{SD}$  ≤ 3.2 A, dI/dt ≤ 90 A/ $\mu$ s, V $_{DD}$  ≤ V $_{DS}$ , T $_J$  ≤ 150 °C.

- d. 1.6 mm from case.
- e. Drain current limited by maximum junction temperature.



| THERMAL RESISTANCE RATINGS       |                   |      |      |      |  |
|----------------------------------|-------------------|------|------|------|--|
| PARAMETER                        | SYMBOL            | TYP. | MAX. | UNIT |  |
| Maximum Junction-to-Ambient      | R <sub>thJA</sub> | -    | 65   | °C/W |  |
| Maximum Junction-to-Case (Drain) | R <sub>thJC</sub> | -    | 2.1  | C/VV |  |

| PARAMETER                                 | SYMBOL                | TEST CONDITIONS   |  | MIN. | TYP. | MAX.      | UNIT             |
|---|-----------------------|---|--|------|------|-----------|------------------|
| Static                                    |                       |   |  |      |      |           |                  |
| Drain-Source Breakdown Voltage            | V <sub>DS</sub>       | V <sub>GS</sub> :   | = 0 V, I <sub>D</sub> = 250 μA   | 650  | -    | -         | V                |
| V <sub>DS</sub> Temperature Coefficient   | $\Delta V_{DS}/T_{J}$ | Referenc  | e to 25 °C, I <sub>D</sub> = 1 mA <sup>d</sup>   | -    | 670  | -         | mV/°C            |
| Gate-Source Threshold Voltage             | V <sub>GS(th)</sub>   | V <sub>DS</sub> =   | = V <sub>GS</sub> , I <sub>D</sub> = 250 μA  | 2.0  | -    | 4.0       | V                |
| Gate-Source Leakage                       | I <sub>GSS</sub>      | ,   | V <sub>GS</sub> = ± 30 V   | ı    | -    | ± 100     | nA               |
| Zero Gate Voltage Drain Current           | I <sub>DSS</sub>      |   | = 650 V, V <sub>GS</sub> = 0 V<br>V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C                  | -    | -    | 25<br>250 | μA               |
| Drain-Source On-State Resistance          | R <sub>DS(on)</sub>   | V <sub>GS</sub> = 10 V  | I <sub>D</sub> = 1 A b   | -    | 4.0  | 5.0       | Ω                |
| Forward Transconductance                  | 9 <sub>fs</sub>       | V <sub>DS</sub>   | = 50 V, I <sub>D</sub> = 1 A   | 3.9  | -    | -         | S                |
| Dynamic                                   |                       |   |  |      | •    | •         |                  |
| Input Capacitance                         | C <sub>iss</sub>      |   | V <sub>GS</sub> = 0 V,   | -    | 417  | -         |                  |
| Output Capacitance                        | C <sub>oss</sub>      | 1   | $V_{DS} = 25 \text{ V},$   | -    | 45   | -         |                  |
| Reverse Transfer Capacitance              | C <sub>rss</sub>      | f = 1   | .0 MHz, see fig. 5   | -    | 5    | -         |                  |
| Output Capacitance                        | C <sub>oss</sub>      |   | V <sub>DS</sub> = 1.0 V, f = 1.0 MHz   | -    | 912  | -         | pF               |
| Output Capacitance                        |                       | $V_{GS} = 0 V$  | V <sub>DS</sub> = 520 V, f = 1.0 MHz   | -    | 26   |           |                  |
| Effective Output Capacitance              | Coss eff.             |   | V <sub>DS</sub> = 0 V to 520 V <sup>c</sup>  | -    | 42   | -         |                  |
| Total Gate Charge                         | $Q_g$                 |   |  | -    | -    | 11        |                  |
| Gate-Source Charge                        | $Q_{gs}$              | V <sub>GS</sub> = 10 V  | $V_{GS} = 10 \text{ V}$ $I_D = 1.2 \text{ A}, V_{DS} = 400 \text{ V}$ see fig. 6 and 13 <sup>b</sup> |      | -    | 2.3       | nC               |
| Gate-Drain Charge                         | Q <sub>gd</sub>       |   |  |      | -    | 5.2       |                  |
| Turn-On Delay Time                        | t <sub>d(on)</sub>    |   | 1  |      | 14   | -         |                  |
| Rise Time                                 | t <sub>r</sub>        |   | = 325 V, I <sub>D</sub> = 1.2A   | i    | 20   | -         |                  |
| Turn-Off Delay Time                       | t <sub>d(off)</sub>   | $R_{G} =$   | 9.1 $\Omega$ , R <sub>D</sub> = 62 $\Omega$ , see fig. 10 <sup>b</sup>                               | -    | 34   | -         | ns               |
| Fall Time                                 | t <sub>f</sub>        |   |  |      | 18   | -         | 1                |
| Drain-Source Body Diode Characteristic    | s                     |   |  |      |      |           |                  |
| Continuous Source-Drain Diode Current     | I <sub>S</sub>        | MOSFET symbol showing the integral reverse p - n junction diode                                   |  | -    | -    | 2         | A                |
| Pulsed Diode Forward Current <sup>a</sup> | I <sub>SM</sub>       |   |  | ı    | -    | 8         | A                |
| Body Diode Voltage                        | $V_{SD}$              | $T_J = 25  ^{\circ}\text{C},  I_S = 3.2  \text{A},  V_{GS} = 0  \text{V}^{\text{b}}$              |  | -    | -    | 1.5       | V                |
| Body Diode Reverse Recovery Time          | t <sub>rr</sub>       | T. = 25 °C L  | T 25 00 1 2 2 A 21/24 400 A / 22h  |      | 180  | 230       | ns               |
| Body Diode Reverse Recovery Charge        | Q <sub>rr</sub>       | $T_J = 25 \text{ °C}, I_F = 3.2 \text{ A}, dI/dt = 100 \text{ A/}\mu\text{s}^b$                   |  | -    | 2.1  | 3.2       | μC               |
| Forward Turn-On Time                      | t <sub>on</sub>       | Intrinsic turn-on time is negligible (turn-on is dominated by L <sub>S</sub> and L <sub>D</sub> ) |  |      |      |           | L <sub>D</sub> ) |

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width  $\leq$  300  $\mu$ s; duty cycle  $\leq$  2 %. c.  $C_{oss}$  eff. is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 % to 80 %  $V_{DS}$ .
- d. t = 60 s, f = 60 Hz.



#### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

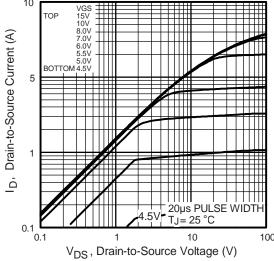


Fig. 1 - Typical Output Characteristics

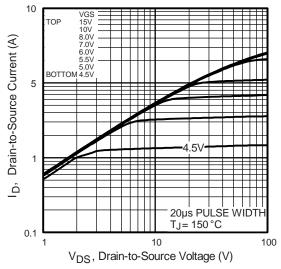


Fig. 2 - Typical Output Characteristics

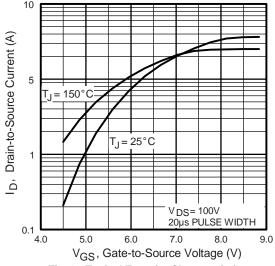


Fig. 3 - Typical Transfer Characteristics

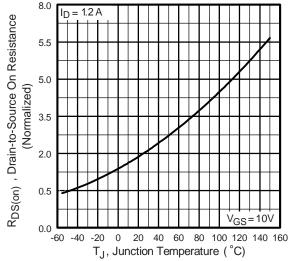


Fig. 4 - Normalized On-Resistance vs. Temperature



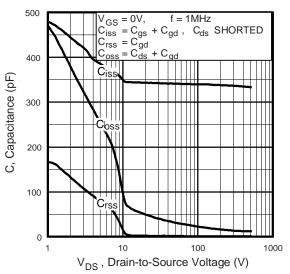


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

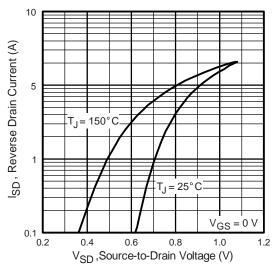


Fig. 7 - Typical Source-Drain Diode Forward Voltage

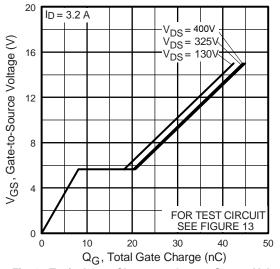


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

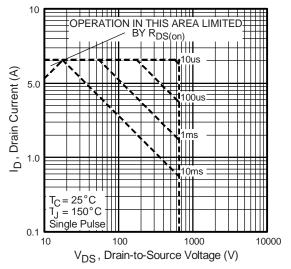


Fig. 8 - Maximum Safe Operating Area



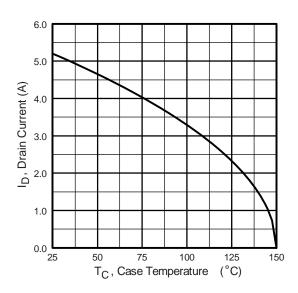


Fig. 9 - Maximum Drain Current vs. Case Temperature

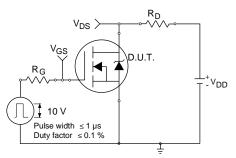


Fig. 10a - Switching Time Test Circuit

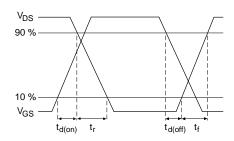


Fig. 10b - Switching Time Waveforms

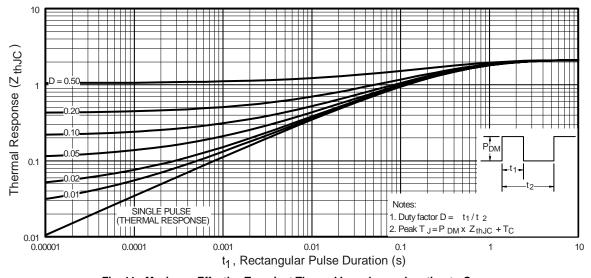


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

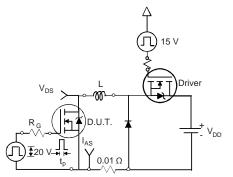


Fig. 12a - Unclamped Inductive Test Circuit

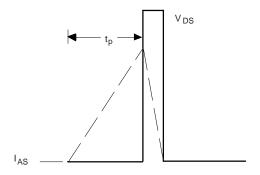


Fig. 12b - Unclamped Inductive Waveforms



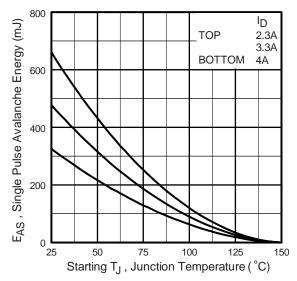


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

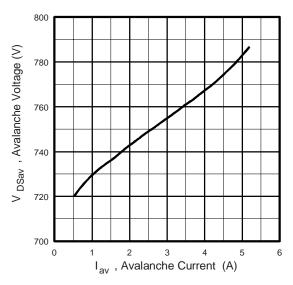


Fig. 12d - Typical Drain-to Source Voltage vs. Avalanche Current

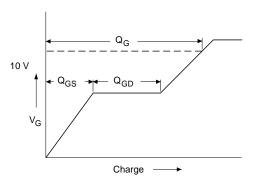


Fig. 13a - Basic Gate Charge Waveform

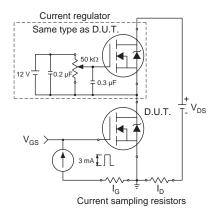
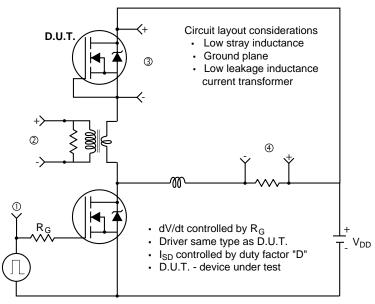
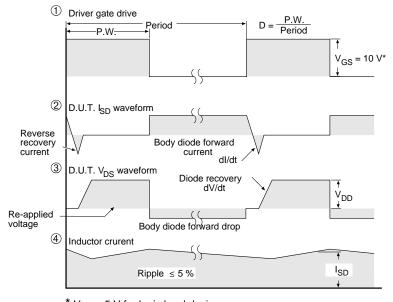


Fig. 13b - Gate Charge Test Circuit



### Peak Diode Recovery dV/dt Test Circuit



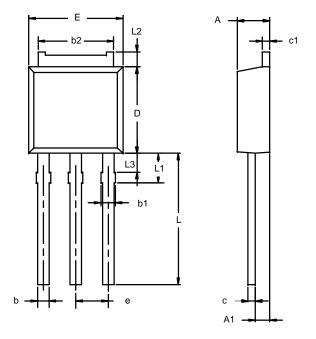


\*  $V_{GS} = 5 \text{ V}$  for logic level devices

Fig. 14 - For N-Channel



### **TO-251AA**



| Note: | Dimension | L3 is for | reference | only. |
|-------|-----------|-----------|-----------|-------|
|-------|-----------|-----------|-----------|-------|

|     | MILLIM | IETERS | INC   | HES   |  |
|-----|--------|--------|-------|-------|--|
| Dim | Min    | Max    | Min   | Max   |  |
| Α   | 2.21   | 2.38   | 0.087 | 0.094 |  |
| A1  | 0.89   | 1.14   | 0.035 | 0.045 |  |
| b   | 0.71   | 0.89   | 0.028 | 0.035 |  |
| b1  | 0.76   | 1.14   | 0.030 | 0.045 |  |
| b2  | 5.23   | 5.43   | 0.206 | 0.214 |  |
| С   | 0.46   | 0.58   | 0.018 | 0.023 |  |
| с1  | 0.46   | 0.58   | 0.018 | 0.023 |  |
| D   | 5.97   | 6.22   | 0.235 | 0.245 |  |
| Е   | 6.48   | 6.73   | 0.255 | 0.265 |  |
| е   | 2.28   | BSC    | 0.090 | BSC   |  |
| L   | 3.89   | 9.53   | 0.153 | 0.375 |  |
| L1  | 1.91   | 2.28   | 0.075 | 0.090 |  |
| L2  | 0.89   | 1.27   | 0.035 | 0.050 |  |
| L3  | 1.15   | 1.52   | 0.045 | 0.060 |  |



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